

Notice of References Cited	Application/Control No. 10/538,270		Applicant(s)/Patent Under Reexamination YAMASHITA ET AL.	
	Examiner Kris Mittal		Art Unit 4115	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0062250	05-2002	Nagano et al.	705/14
*	B	US-2004/0221018	11-2004	Ji, Eun-Mook	709/217
*	C	US-2002/0019774	02-2002	Kanter, Andrew S.	705/14
*	D	US-2004/0003396	01-2004	Babu, Suresh P.	725/34
*	E	US-7,043,526	05-2006	Wolfe, Mark A.	709/203
*	F	US-6,466,967	10-2002	Landsman et al.	709/203
*	G	US-6,336,131	01-2002	Wolfe, Mark A.	709/203
*	H	US-6,411,992	06-2002	Srinivasan et al.	709/218
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.